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BUBLEWITZ ET AL-14 PCT

In re Application of: Alexander BUBLEWITZ ET AL		
Application No.: 10/589,329 AUG 1 4 2009		
Filed: AUGUST 14, 2006		
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Vol. 3, No. 1

Strong and Hindered Bases in Organic Synthesis

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Introduction / Phosphazene Bases / Verkade's Superbases / Traditional bases Preservation of Reagents / Aldrich Schlenk-Type Glassware / Miscettaneous Information

Phosphazene Bases

Introduction / Monomeric Phosphazere Bases (Pt)
Dimeric Phosphazene Bases (P2) / Tetrameric Phosphazene Bases (P4)

Tetrameric Phosphazene Bases (P4)

The two P4 phosphazene bases offered by Fluka differ slightly with respect to their steric hindrance and basicity (Table 5).

Table 5, Order of Basicity for P4 Bases

Order of steric hindrance:	P4-I-Oct	>>	P4-1-B
Fluka Product Number:	79422		79421
Basicity (MeCNpKBH+):	42.7		41.9

P44-Bu^[1] 79421 and P44-Oct 78422, offered as 1 M solutions in hexane have several important features. They are highly sterically hindered, extremely hygroscopic, highly stable towards hydrolysis, 18 orders of magnitude more basic than DBU, [2] and already in the basicity range typical of organolithium bases. Both 79421 and 79422 are particularly suitable for deprotonation (activation) of pronucleophiles, although also deprotonations for spectroscopic investigations, [3-7] epimerisations, [8] double bond shifts, [9] b-eliminations, [9-12] and LH complexation (alkyllithlum activation)[13,14] have been reported. See Table 6 for a list of our P2 bases with their properties, package size etc.

Table 6, Phospazene bases P4

79421

Phosphazene base P4-t-Bu solution

1-tert-Butyl-4,4,4-tris(dimethylamino)-2,2-bis[tris(dimethylamino)phosphoranylidenamino]-2/5,4/5-catenadi(phosphazena)

purum, ~1.0 M in n-hexane C22He3N13P4 Mr 633.7 [111324-04-0] 1 ml, 5 ml, 25 ml

79422 LICENS 2

Phosphazene base P4-t-Oct solution

1-tert-Octyl-4,4,4-tris(dimethylamino)-2,2-bis[tris(dimethylamino) phosphorarylidenamino]-2/5,4/5-catenadi(phosphazene)

purum, 1.00 M ± 0.02 M in n-hexane C₂₆H₇₁N₁₃P₄ Mr 689.8 [153136-05-1] 1 ml, 5 ml

Applications: These bases attract increasing interest in the field of anionic copolymerisation [13-18] and have also been utilized for solid-phase synthesis^[6] related to combinatorial chemistry. [19,20] They have been reported to support alkylations, [1,21-31] Michael-additions, [15,32,33] aldolreactions, [28,34-37], epoxide-opening, [17,19,38,39] acytations, [40] sulfortylations, [41] anionic oxy-Cope rearrangements, [42] oxidation of carbanions[37], and transition metal-induced coupling reactions. [29,43] Among the successfully converted low acidic substrates are elcohols [35,42], amides [39,41], peptides (N- and C-activation), [24] perphyrines, [4] phosphines, [25] H-phosphonates, [31] esters, [5,25,27,35] Q-alkowesters [21] and -factones [23][21][8], and b, g, d-factones [23,20] thioesters [40] suffores [3,34] episulfones, [28] benzolhiazole, [21] and benzyl anyl ethers. [36] 6-Hydroxysulfones, [34] phosphonothicates, [31] encl triflates, [40] benzoturanes, [36] and subphthalocyanines [44] are thus efficiently synthesized.

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